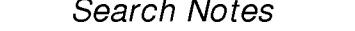


<i>Search Notes</i> 	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/804,171	CHO ET AL.	
	Examiner	Art Unit	
	Douglas J. Duff	3748	

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner